

Application/Control No.	Applicant(s)/Patent under Reexamination
10/082,470	CHALKE ET AL.
Examiner	Art Unit

Hai Tran

3694

	SEARCHED					
Class	Subclass	Date	Examiner			
705	36	10/12/2007	нт			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
PALM inventor search	10/11/2007	нт			
EAST Tool search	10/11/2007	нт			